

Journal Information

Journal Title	WSEAS Transactions on Electronics
Publisher	World Scientific and Engineering Academy and Society
ISSN	1109-9445
E-ISSN	2415-1513
Database	SCOPUS
Domain	Physical Sciences

Classification History

Year	A+	A	B	C
2026			✓	
2025			✓	
2024			✓	
2023			✓	
2021/2022			✓	
2020			✓	
2019			✓	
2018				

Classification: The table above shows all journal classifications recorded for each classification year in the Green Journals database. A journal may have more than one classification in the same year.

Recent Articles

The Quality Imperative in High Volume Production of Electronic chips 2026-10-26 Vol. 17 Pages 37 Authors: Hesham M. Enshasy DOI: 10.37394/232017.2026.17.4
Porous Silicon-Integrated Germanium Quantum Dots for Advanced Radiation Detector Applications 2026-10-5 Vol. 17 Pages 22 Authors: Natheer A. Algadri, Ahmad M. Al-Diabat, Naser M. Ahmed DOI: 10.37394/232017.2026.17.3
Nonlinear Modelling Of Ultrafast Free-Electron Dynamics and Transient Reflectivity in Water-Like Media under Femtosecond Laser Excitation 2026-7-13 Vol. 17 Pages 11 Authors: Violeta Petrović, Hristina Delibašić Marković, Ivan Petrović DOI: 10.37394/232017.2026.17.2
Edge Computing Device with Embedded Intelligence for Health Status Classification 2026-5-19 Vol. 17 Pages 1 Authors: Ricardo Yauri, Nora Bertha La Serna Palomino DOI: 10.37394/232017.2026.17.1
Research on Electronic Monitoring SystemsForThe Drilling ProcessIn Antarctic Conditions 2025-12-31 Vol. 16 Pages 189 Authors: Irina Rastvorova, Vladimir Smirnov DOI: 10.37394/232017.2025.16.19

Accessibility and Culture: Drivers of Social Cohesion and Well-being 2025-12-31 Vol. 16 Pages 200 Authors: Ioanna Maniou, Pinelopi Soritopoulou, Maria Manola et al. DOI: 10.37394/232017.2025.16.20
A Low Voltage AC Input Boost Fly Back Converter as a High Power Factor Off-Line Power Supply 2025-12-31 Vol. 16 Pages 211 Authors: Sravan Kumar S. L. V., Ravisankara Reddy N., Vijaya Kumar M. et al. DOI: 10.37394/232017.2025.16.21
Comprehensive Analysis of Fundamental Dynamics in Laser-Induced Breakdown of Solid Materials 2025-10-14 Vol. 16 Pages 179-188 Authors: Violeta Petrović, Hristina Delibašić-Marković, Ivan Petrović DOI: 10.37394/232017.2025.16.18
Investigation of MOSFET Transistor Reliability under Pulsed-RF Life Tests 2025-10-7 Vol. 16 Pages 150-156 Authors: Ahmed Almusallam, Mohamed Ali Belaid DOI: 10.37394/232017.2025.16.15
Implementation of a TRNG Architecture based on Different Entropy Sources 2025-10-7 Vol. 16 Pages 168-178 Authors: Manoj Kumar DOI: 10.37394/232017.2025.16.17